Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	oplicant(s)/Patent under sexamination	
10/757,901	OIKAWA ET AL.		
Examiner	Art Unit	_	
Alain L. Bashore	1762		

SEARCHED					
Class	Subclass	Date	Examiner		
427	127, 128, 130, 121 132	9/18/2005	АВ		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	1			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST (attached)	9/18/2005	АВ		
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